## STL90N3LLH6



# N-channel 30 V, 0.0038 Ω typ., 24 A STripFET<sup>TM</sup> VI DeepGATE<sup>TM</sup> Power MOSFET in PowerFLAT<sup>TM</sup> 5x6 package

Datasheet - production data

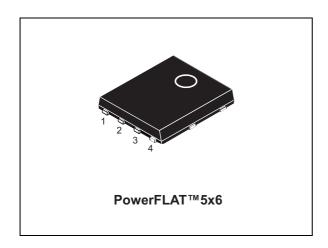
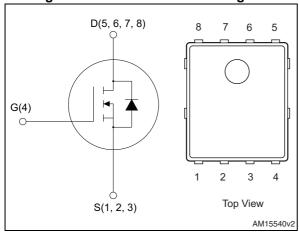


Figure 1. Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STL90N3LLH6	30 V	$0.0045\Omega$	24 A (1)

- 1. The value is rated according R<sub>thi-pcb</sub>
- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- · High avalanche ruggedness
- Low gate drive power losses
- Very low switching gate charge

#### **Applications**

• Switching applications

#### **Description**

This device is an N-channel Power MOSFET developed using the 6<sup>th</sup> generation of STripFET<sup>TM</sup> DeepGATE<sup>TM</sup> technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest R<sub>DS(on)</sub> in all packages.

Table 1. Device summary

Order code	Marking	Packages	Packaging
STL90N3LLH6	90N3LLH6	PowerFLAT™ 5x6	Tape and reel

Contents STL90N3LLH6

## **Contents**

1	Electrical ratings	3
2	Electrical characteristics	4
	2.1 Electrical characteristics (curves)	6
3	Test circuits	8
4	Package mechanical data	9
5	Revision history	15

STL90N3LLH6 Electrical ratings

## 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	30	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	90	А
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 70 °C	67.5	А
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100 °C	56.2	А
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>pcb</sub> = 25 °C	24	А
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>pcb</sub> = 70 °C	18	А
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>pcb</sub> =100 °C	15	А
I <sub>DM</sub> <sup>(2) (3)</sup>	Drain current (pulsed)	96	А
I <sub>DM</sub> <sup>(1) (3)</sup>	Drain current (pulsed)	360	А
P <sub>TOT</sub> (1)	Total dissipation at T <sub>C</sub> = 25 °C	60	W
P <sub>TOT</sub> (2)	Total dissipation at T <sub>pcb</sub> = 25 °C	4	W
	Derating factor	0.03	W/°C
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 150	°C

- 1. The value is rated according to  $R_{\mbox{\scriptsize thj-c}}$
- 2. The value is rated according to  $R_{\mbox{\scriptsize thj-pcb}}$
- 3. Pulse width limited by safe operating area

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case (drain, steady state)	2.08	°C/W
R <sub>thj-pcb</sub> (1)	Thermal resistance junction-ambient	31.3	°C/W

<sup>1.</sup> When mounted on FR-4 board of 1inch $^2$ , 2oz Cu, t < 10 sec

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
H	Single pulse avalanche energy (starting $T_J = 25$ °C, $I_D = 12$ A; L= 1.25mH)	90	mJ

Electrical characteristics STL90N3LLH6

## 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	30			V
1	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 30 V,			1	μΑ
I <sub>DSS</sub>		V <sub>DS</sub> = 30 V T <sub>C</sub> = 125 °C			10	μA
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	1.7	2.5	V
Static drain-source on-	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 12 A		0.0038	0.0045	Ω	
R <sub>DS(on)</sub>	resistance	$V_{GS}$ = 4.5 V, $I_{D}$ = 12 A		0.0057	0.0073	Ω

#### Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		1350	1690	2030	pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 25 V, f=1 MHz,	230	290	350	pF
C <sub>rss</sub>	Reverse transfer capacitance	V <sub>GS</sub> =0	140	176	210	pF
Qg	Total gate charge	V <sub>DD</sub> =15 V, I <sub>D</sub> = 24 A		17		nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> =4.5 V (see Figure 14)		8		nC
Q <sub>gd</sub>	Gate-drain charge			6		nC
R <sub>G</sub>	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain	1.25	1.7	2	Ω

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time		-	9.5	-	ns
t <sub>r</sub>	Rise time	$V_{DD}$ =15 V, $I_{D}$ = 12 A, $R_{G}$ =4.7 $\Omega$ , $V_{GS}$ =10 V (see Figure 13)	-	30	-	ns
t <sub>d(off)</sub>	Turn-off delay time		-	37	-	ns
t <sub>f</sub>	Fall time	,	-	12	-	ns

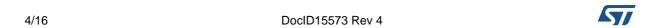


Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		24	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		96	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 24 A, V <sub>GS</sub> =0	-		1.1	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 12 A,	-	24		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt = 100 A/μs,	-	16.8		nC
I <sub>RRM</sub>	Reverse recovery current	V <sub>DD</sub> =25 V	-	1.4		Α

<sup>1.</sup> Pulse width limited by safe operating area

<sup>2.</sup> Pulsed: pulse duration=300µs, duty cycle 1.5%

Electrical characteristics STL90N3LLH6

### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

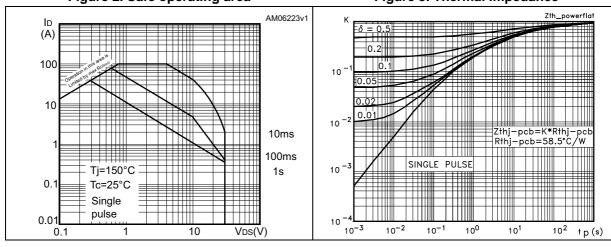


Figure 4. Output characteristics

Figure 5. Transfer characteristics

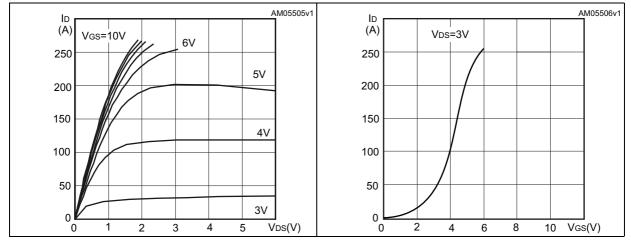
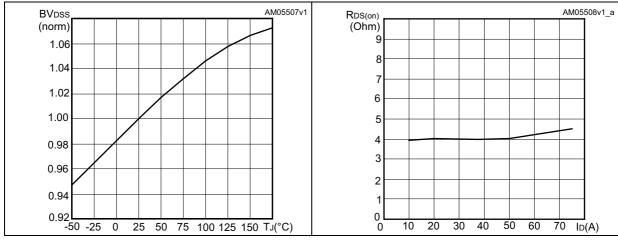


Figure 6. Normalized  $\mathrm{BV}_{\mathrm{DSS}}$  vs temperature

Figure 7. Static drain-source on-resistance



6/16 DocID15573 Rev 4

Figure 8. Gate charge vs gate-source voltage

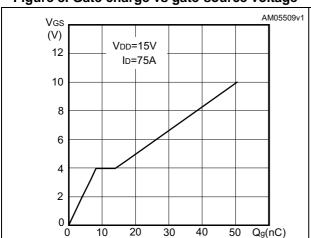


Figure 9. Capacitance variations

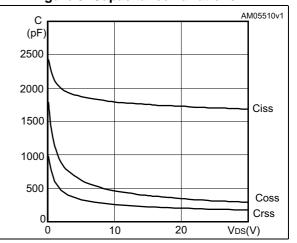
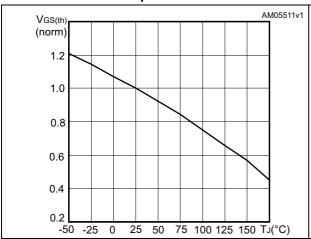


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



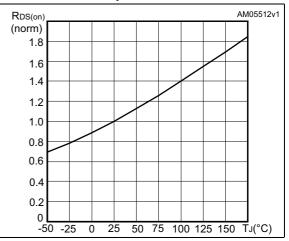
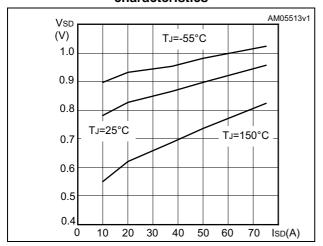


Figure 12. Source-drain diode forward characteristics



Test circuits STL90N3LLH6

## 3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

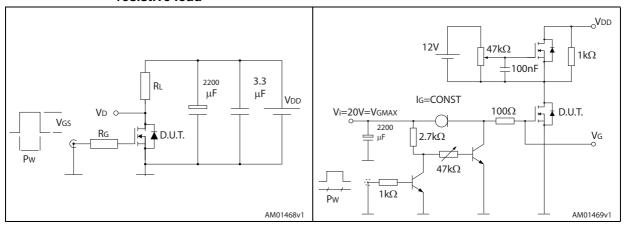


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

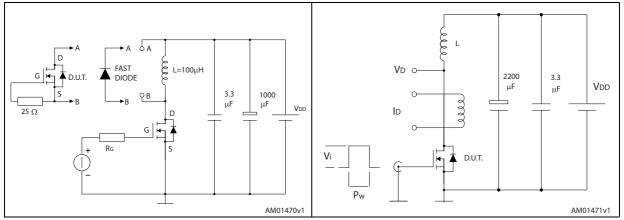
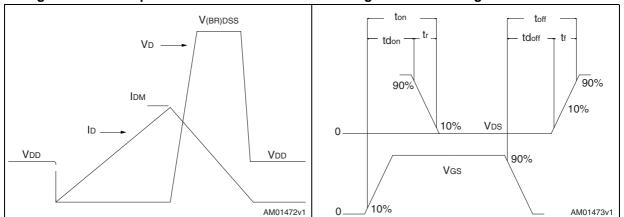


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



57/

## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.



Table 9. PowerFLAT™ 5x6 type C-B mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	0.80	0.83	0.93
A1	0	0.02	0.05
A3		0.20	
b	0.35	0.40	0.47
D		5.00	
D1		4.75	
D2	4.15	4.20	4.25
E		6.00	
E1		5.75	
E2	3.43	3.48	3.53
E4	2.58	2.63	2.68
е		1.27	
L	0.70	0.80	0.90

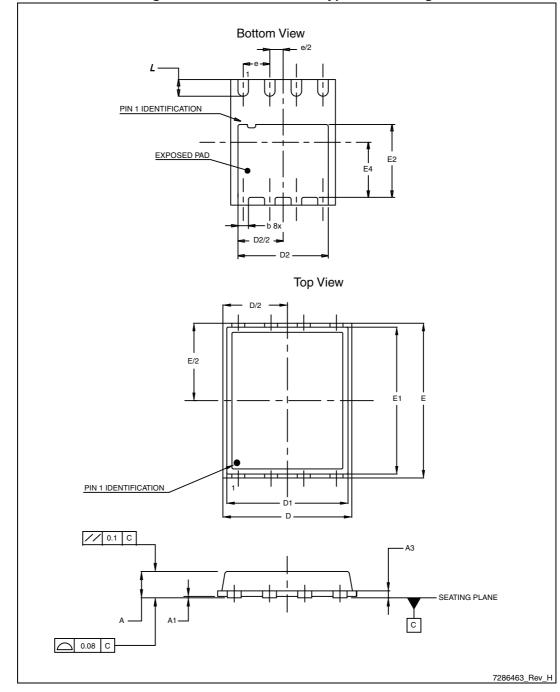


Figure 19. PowerFLAT™ 5x6 type C-B drawing

Table 10. PowerFLAT™ 5x6 type S-C mechanical data

Dim.		mm	
Dilli.	Min.	Тур.	Max.
А	0.80		1.00
A1	0.02		0.05
A2		0.25	
b	0.30		0.50
D		5.20	
Е		6.15	
D2	4.11		4.31
E2	3.50		3.70
е		1.27	
e1		0.65	
L	0.715		1.015
K	1.05		1.35

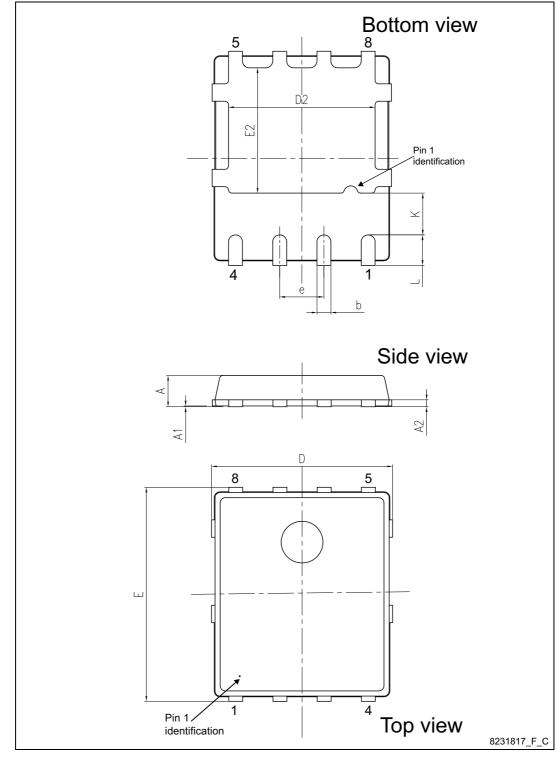


Figure 20. PowerFLAT™ 5x6 type S-C mechanical data

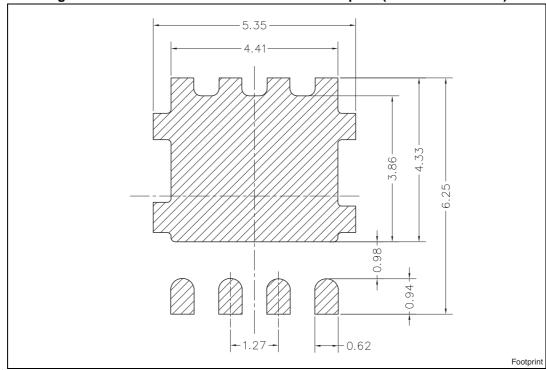


Figure 21. PowerFLAT™ 5x6 recommended footprint (dimensions in mm)

577

STL90N3LLH6 Revision history

# 5 Revision history

**Table 11. Document revision history** 

Date	Revision	Changes
10-Apr-2009	1	First release
17-Mar-2010	2	<ul> <li>Inserted new values on <i>Table 5</i>, <i>Table 6</i> and <i>Table 8</i></li> <li>Document status promoted from preliminary data to datasheet.</li> </ul>
10-Nov-2011	3	Inserted I <sub>D</sub> value @ 70 °C, in <i>Table 2: Absolute maximum ratings</i> .  Section 4: Package mechanical data has been updated.  Minor text changes.
03-Sep-2013	4	<ul> <li>Updated: title and Figure 1 in the cover page.</li> <li>Updated: Section 4: Package mechanical data</li> <li>Updated: Figure 13, 14, 15 and 16</li> <li>Added new Table 4: Avalanche characteristics.</li> <li>Minor text changes</li> <li>Document status promoted from preliminary to production data.</li> </ul>

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16/16 DocID15573 Rev 4